Temperature dependence of the energy and broadening parameter of the fundamental band gap
of GaSb and Ga$_{1-x}$In$_x$As$_y$Sb$_{1-y}$/GaSb (0.07$\leq x \leq 0.22$, 0.05$\leq y \leq 0.19$) quaternary alloys
using infrared photoreflectance

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We have measured the temperature dependence of the energy [$E_0(T)$] and broadening parameter [$\Gamma_0(T)$] of the fundamental gap for GaSb and four samples of Ga$_{1-x}$In$_x$As$_y$Sb$_{1-y}$ (lattice matched to GaSb) using infrared photoreflectance. The parameters that describe the temperature variation of the energy (including thermal-expansion effects) were evaluated using both the semiempirical Varshni relation as well as an equation that incorporates the Bose-Einstein occupation factor. The behavior of $\Gamma_0(T)$ was described by a Bose-Einstein-type equation.

I. INTRODUCTION

The quaternary alloy Ga$_{1-x}$In$_x$As$_y$Sb$_{1-y}$ lattice matched to GaSb is a narrow-band-gap semiconductor (~0.3–0.7 eV at room temperature) with a number of applications including thermophotovoltaic (TPV) cells, infrared light-emitting diodes, and lasers, as well as photodetectors. The temperature dependence of the fundamental band gap [$E_0(T)$] and the broadening parameter [$\Gamma_0(T)$] are of interest for basic reasons as well as for various applications. The temperature dependence of the energy and linewidth of electronic transitions give important information about the electron-phonon interactions, excitonic effects, etc. From an applied point of view, the ability to measure the band gap at temperatures corresponding to device operating conditions, e.g., 300–350 K for the TPV cells, makes it possible to model certain semiconductor properties at these temperatures. For example, the absorption coefficient of the fundamental gap at these conditions can be evaluated using our previous ellipsometric results on GaSb (Ref. 13) and GaInAsSb (Ref. 14) in conjunction with a comprehensive model for the dielectric function which involves both discrete and continuous excitonic effects at the $E_0/E_0 + \Delta_0$ and $E_1/E_1 + \Delta_1$ critical points.

However, in spite of its significance, few works on the temperature dependence of the fundamental band gap of GaSb have been reported and none for these quaternary compounds. An early study of $E_0(T)$ of GaSb was done by Joulié et al. using Schottky barrier electroreflectance between 30 and 300 K. However, the data were fit using only a linear term which produced an overestimation of the value of $E_0(0)$, which is frequently quoted in the literature. There are reports of the temperature dependence of the higher lying transition $E_0 + \Delta_0$ between 4 and 300 K (Ref. 18) and $E_0 + \Delta_0$, $E_1$, $E_1 + \Delta_1$ between 83 and 300 K.

In this work we present the temperature dependence of $E_0(T)$ and the related broadening parameter [$\Gamma_0(T)$] for the fundamental gap of GaSb and four Ga$_{1-x}$In$_x$As$_y$Sb$_{1-y}$/GaSb (001) (0.07$\leq x \leq 0.22$, 0.05$\leq y \leq 0.19$) quaternary alloys, using infrared-photoreflectance (IRPR) between 15 and 377 K. The four quaternary samples have compositions of $(x = 0.07, y = 0.05)$, $(x = 0.09, y = 0.07)$, $(x = 0.12, y = 0.11)$, and $(x = 0.22, y = 0.19)$. The band gap of the quaternaries decreases with increasing In composition. In narrow-band-gap materials the applications of photoreflectance (PR) have been limited by the low values of the built-in field. However, to our knowledge there has been no study of the PR applicability limits to these narrow-band-gap materials. During this study we were able to test the usefulness of PR for these materials. The temperature dependence of band gaps has been described by equations involving three parameters, such as the Varshni expression or one containing the Bose-Einstein occupation factor for phonons and involving the electron-average phonon (acoustical and optical) interaction. By taking into account the component of the energy gap shift due to the thermal-expansion coefficient, we have obtained revised parameters which are directly related to the electron-average phonon interaction in the latter case. A somewhat similar Bose-Einstein-type equation, involving the electron-longitudinal optical (LO) phonon at $q \approx 0$ (Fröhlich interaction), has been used to fit the temperatures dependence of the broadening function.

II. EXPERIMENTAL DETAILS

The GaSb and the Ga$_{1-x}$In$_x$As$_y$Sb$_{1-y}$ epitaxial layers, lattice matched to GaSb (001) substrates, were grown by liquid
TABLE I. Carrier concentration and type as well as lattice-mismatch data of the studied samples.

<table>
<thead>
<tr>
<th>Sample</th>
<th>Carrier concentration/type (10^16 cm^-2)</th>
<th>\Delta a/a (10^-4)</th>
</tr>
</thead>
<tbody>
<tr>
<td>GaSb</td>
<td>17/n^a</td>
<td>0</td>
</tr>
<tr>
<td>Ga_{0.90}In_{0.10}As_{0.05}Sb_{0.95}</td>
<td>6/p^b</td>
<td>0</td>
</tr>
<tr>
<td>Ga_{0.92}In_{0.08}As_{0.05}Sb_{0.93}</td>
<td>5/p^b</td>
<td>5.1</td>
</tr>
<tr>
<td>Ga_{0.88}In_{0.12}As_{0.11}Sb_{0.89}</td>
<td>4/n^a</td>
<td>2</td>
</tr>
<tr>
<td>Ga_{0.78}In_{0.22}As_{0.19}Sb_{0.81}</td>
<td>2/p^b</td>
<td>-3.5</td>
</tr>
</tbody>
</table>

^aTe doping.
^bNominally undoped.

III. EXPERIMENTAL RESULTS AND ANALYSIS

The solid lines in Figs. 1(a)–1(c), are the experimental IRPR spectra for GaSb, and quaternary samples Ga_{0.88}In_{0.12}As_{0.11}Sb_{0.89} and Ga_{0.78}In_{0.22}As_{0.19}Sb_{0.81}, respectively, at three different temperatures. The curves for different temperatures have been displaced for clarity. The dashed lines are least-squares fits to line-shape function yielding the \( E_0(T) \) values indicated by arrows. The curves have been displaced for clarity.

The Varshni equation is given by

\[
E_0(T) = E_0(0) - \frac{\alpha T^2}{\beta + T},
\]

where \( E_0(0) \) is the band gap at \( T = 0 \) K while \( \alpha \) and \( \beta \) are the so-called Varshni coefficients. The Bose-Einstein-type expression, which involves electron coupling to an average phonon (optical and acoustical), is given by

\[
E_0(T) = E_0(0) - \frac{2 a_B}{\exp(\Theta_B/T) - 1},
\]

where \( a_B \) is the strength of the electron-average phonon interaction and \( \Theta_B \) is the average phonon temperature.

The dashed and solid lines in Fig. 2 are least-squares fits to Eqs. (1) and (2), respectively. Listed in Table II are the obtained values of \( E_0(0) \), \( \alpha \), \( \beta \), \( a_B \) and \( \Theta_B \) for the five samples.
The temperature shift of $E_0(T)$ contains contributions from both thermal-expansion and electron-average phonon effects. Therefore, in order to obtain parameters directly related to the latter interaction, it is necessary to eliminate the effects of the former. The energy shift $\Delta E_{\text{th}}$ due to the thermal expansion can be written as \(^{23}\)

$$\Delta E_{\text{th}} = -3a_H \int_0^T \alpha_{\text{th}}(T) dT,$$

(3)

where $a_H$ is the hydrostatic deformation potential and $\alpha_{\text{th}}(T)$ is the linear-expansion coefficient. In order to remove the thermal-expansion contribution to $E_0(T)$ we rewrite Eqs. (1) and (2) as \(^{23}\)

$$E_0(T) - \Delta E_{\text{th}} = E_0'(0) - \frac{\alpha' T^2}{\beta' + T},$$

(4)

$$E_0(T) - \Delta E_{\text{th}} = E_0'(0) - \frac{2a_B}{\exp(\Theta_B/\beta') - 1},$$

(5)

respectively.

While $\alpha_{\text{th}}(T)$ and the hydrostatic deformation potential ($a$) for GaSb are known, in order to evaluate these quantities for the quaternary compounds we used an interpolation scheme based on the four binaries:

$$Q_{\text{quat}}(x,y) = xQ_{\text{InAs}} + x(1-y)Q_{\text{InSb}} + y(1-x)Q_{\text{GaAs}} + (1-x)(1-y)Q_{\text{GaSb}},$$

(6)

where $Q_i = \alpha_{\text{th},i}$ or $a_i$ ($i = \text{quat}, \text{InAs}$, etc). The data for the binary compounds were taken from Refs. 25 and 26.

The solid and open symbols in Fig. 3 are $E_0(T)$ and $E_0(T) - \Delta E_{\text{th}}(T)$, respectively, for the GaSb and Ga$_{0.78}$In$_{0.22}$As$_{0.19}$Sb$_{0.81}$ samples. For clarity we show only these two materials. The dashed and solid lines represent least-squares fits to Eqs. (2) and (5), respectively. The data have also been fit using Eq. (4). The obtained values for $E_0'(0)$, $a_B'$, $\Theta_B'$, $\alpha'$, and $\beta'$ are presented in the Table III.

The temperature dependence of the linewidth [full width at half maximum (FWHM)], can be expressed as \(^{11,12}\)

$$\Gamma_0(T) = \Gamma_0(0) + \frac{\Gamma_{\text{LO}}}{\exp(\Theta_{\text{LO}}/T) - 1},$$

(7)

where $\Gamma_0(0)$ is the broadening mechanism due to intrinsic lifetime, electron-electron interaction, impurity, dislocation, and alloy scattering effects, $\Gamma_{\text{LO}}$ is the electron-LO phonon coupling constant (Fröhlich interaction) and $\Theta_{\text{LO}}$ is the LO phonon temperature.

In Fig. 4 the closed squares are the experimental values of $\Gamma_0(T)$ for the GaSb and Ga$_{0.78}$In$_{0.22}$As$_{0.19}$Sb$_{0.81}$ samples, respectively. For clarity the corresponding data for the other samples are not shown. Because of the error bars on our data it was necessary to fix the parameter $\Theta_{\text{LO}}$ in order to obtain the two significant quantities $\Gamma_0(0)$ and $\Gamma_{\text{LO}}$ by means of a least-squares fit of Eq. (7). The estimation of $\Theta_{\text{LO}}$ for the quaternary samples has been done using the interpolation scheme given by Eq. (6), the corresponding binary values were obtained from Ref. 25. The solid lines in Fig. 4 are least-squares fits to Eq. (7). Listed in Table IV are the obtained values of $\Gamma_0(0)$ and $\Gamma_{\text{LO}}$ as well as $\Theta_{\text{LO}}$ (fixed).

### IV. DISCUSSION OF RESULTS

Mannogian and Woolley\(^{27}\) have suggested that after the thermal-expansion term is removed the parameter $\beta'$ of Eq. (4) is related to the Debye temperature ($\Theta_D$) by $\beta' = 3/8\Theta_D$. Listed in Table III are $\frac{1}{2}\Theta_D$ for GaSb and the four quaternaries, the latter $\Theta_D$ being evaluated using Eq. (6) and the binary values from Refs. 25 and 26. There is good agreement between the values of $\beta'$ and $\frac{1}{2}\Theta_D$.

From the high-temperature limit of Eqs. (4) and (5) the parameters $\alpha'$, $a_B'$, and $\Theta_B'$ are related by $\alpha' = 2a_B'/\Theta_B'$.

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**TABLE II. Values of the Varshni [Eq. (1)] and Bose-Einstein-type [Eq. (2)] fit parameters for GaSb and the four quaternary samples.**

<table>
<thead>
<tr>
<th>Sample</th>
<th>$E_0(0)$ (eV)</th>
<th>$\alpha$ ($10^{-4}$ eV/K)</th>
<th>$\beta$ (K)</th>
<th>$E_0(0)$ (eV)</th>
<th>$a_B$ (meV)</th>
<th>$\Theta_B$ (K)</th>
</tr>
</thead>
<tbody>
<tr>
<td>GaSb</td>
<td>0.809 ± 0.005</td>
<td>5.3 ± 0.4</td>
<td>234 ± 40</td>
<td>0.809 ± 0.005</td>
<td>35 ± 5</td>
<td>175 ± 30</td>
</tr>
<tr>
<td>Ga$<em>{0.91}$In$</em>{0.09}$As$<em>{0.07}$Sb$</em>{0.93}$</td>
<td>0.721 ± 0.005</td>
<td>5.2 ± 0.4</td>
<td>274 ± 40</td>
<td>0.721 ± 0.005</td>
<td>38 ± 5</td>
<td>198 ± 30</td>
</tr>
<tr>
<td>Ga$<em>{0.92}$In$</em>{0.08}$As$<em>{0.11}$Sb$</em>{0.89}$</td>
<td>0.683 ± 0.005</td>
<td>3.9 ± 0.4</td>
<td>250 ± 40</td>
<td>0.682 ± 0.005</td>
<td>27 ± 5</td>
<td>186 ± 30</td>
</tr>
<tr>
<td>Ga$<em>{0.86}$In$</em>{0.12}$As$<em>{0.11}$Sb$</em>{0.89}$</td>
<td>0.641 ± 0.005</td>
<td>4.7 ± 0.4</td>
<td>271 ± 40</td>
<td>0.641 ± 0.005</td>
<td>32 ± 5</td>
<td>188 ± 30</td>
</tr>
<tr>
<td>Ga$<em>{0.78}$In$</em>{0.22}$As$<em>{0.19}$Sb$</em>{0.81}$</td>
<td>0.594 ± 0.005</td>
<td>4.0 ± 0.4</td>
<td>290 ± 40</td>
<td>0.593 ± 0.005</td>
<td>26 ± 5</td>
<td>191 ± 30</td>
</tr>
</tbody>
</table>

![FIG. 3. The solid and open symbols represent $E_0(T)$ values with and without the thermal-expansion contribution, respectively. Representative bars are shown. The dashed and continuous lines represent the fits according to Eqs. (2) and (5), respectively.](image-url)
Table III shows that this relationship is indeed satisfied. The results in Fig. 3 show that the thermal-expansion effect is responsible for only about 4% of the total band-gap variation at room temperature.

The analysis of Joullié et al. for \( E_0(T) \) of GaSb consisted of only a linear fit between 100 and 300 K with a slope of \(-3.5 \times 10^{-4} \text{ eV/K}\). Using this value and \( E_0(300 \text{ K}) = 0.72 \text{ eV} \), the extrapolated number is \( E_0(0) = 0.825 \text{ eV} \), which is the value frequently quoted in the literature. However, \( E_0(T) \) for direct gap semiconductors at low temperatures differs considerably from a straight line and hence \( E_0(0) \) has been overestimated by Ref. 16. Our value for this parameter, using both the Varshni and the Bose-Einstein-type equations, is \( E_0(0) = 0.809 \text{ eV} \), which is in agreement with the value of 0.8099 eV obtained from photoluminescence measurements at 2 K.

The value of \( \alpha(5.26 \pm 0.4) \times 10^{-4} \text{ eV/K} \) for \( E_0 \) in GaSb reported in this work is in good agreement with those presented by Hwang et al. (\( \alpha = 6.5 \times 10^{-4} \text{ eV/K} \)) and Iyer et al. (\( \alpha = 5.5 \times 10^{-4} \text{ eV/K} \)) for the \( E_0 + \Delta_0 \) transition. While our number for \( \beta \) (234 \pm 40 K) is similar to Hwang et al. (230 K) it is somewhat higher than that of Ref. 18 (175 K).

Our values for \( \Gamma_{LO} \) are considerably smaller than those reported previously for a number of III-V (GaAs, InGaAs) and II-VI [ZnSe, CdSe (cubic), ZnCdSe] zinc-blende-type semiconductors, except for two measurements of \( \Gamma_{LO} \) = 7–8 meV for GaAs. This difference may be due to the relatively weak Fröhlich coupling constant \( C_F \) in our samples in relation to the other reported zinc-blende materials, where

\[
C_F \propto \left[ \frac{\Theta_{LO}}{e_\infty - 1} \frac{1}{e_0} \right]^{1/2}.
\]

In this equation \( e_\infty \) and \( e_0 \) are the high-frequency and the static dielectric constants, respectively. For example, using the data of Ref. 26 we obtained \( C_F(\text{GaSb})/C_F(\text{GaAs}) = 0.56 \) and \( C_F(\text{GaSb})/C_F(\text{ZnSe}) = 0.30 \).

The band-gap values at room temperature of our samples agree with those presented in Table I by DeWintert et al. However, neither the relations for the band gap as function of the composition presented by these authors nor the one presented by Wang et al. provide a good description of \( E_0 \) for indium compositions higher than 10%. The use of any of these relations to determine the composition of rich indium films can produce compositions errors up to 5%, including one of our previous reports.

### IV. SUMMARY

In this work we have presented the temperature dependence of the fundamental band gap and broadening parameter of GaSb and four \( \text{Ga}_x\text{In}_{1-x}\text{As}_{y}\text{Sb}_{1-y} \) alloys between 14 and 377 K. We have described \( E_0(T) \) in terms of both the Varshni and Bose-Einstein-type equations. As a consequence of this analysis we obtained the correct value for \( E_0(0) = 0.809 \text{ eV} \) for GaSb and the corresponding ones for the quaternaries compounds. In addition, we have separated the thermal-expansion and electron-average phonon contributions to \( E_0(T) \) and concluded that the former is responsible

### TABLE IV. Values of the Bose-Einstein-type [Eq. (7)] fit parameters for GaSb and the four quaternary samples.

<table>
<thead>
<tr>
<th>Sample</th>
<th>( \Gamma_0 ) (meV)</th>
<th>( \Gamma_{LO} ) (meV)</th>
<th>( \Theta_{LO} ) (K)</th>
</tr>
</thead>
<tbody>
<tr>
<td>GaSb</td>
<td>10.4 ± 0.5</td>
<td>7 ± 3</td>
<td>335a</td>
</tr>
<tr>
<td>( \text{Ga}<em>0.9\text{In}</em>{0.1}\text{As}<em>{0.05}\text{Sb}</em>{0.95} )</td>
<td>12.2 ± 0.5</td>
<td>7 ± 3</td>
<td>332.9a</td>
</tr>
<tr>
<td>( \text{Ga}<em>0.9\text{In}</em>{0.1}\text{As}<em>{0.05}\text{Sb}</em>{0.95} )</td>
<td>11.8 ± 0.5</td>
<td>9 ± 3</td>
<td>332.9a</td>
</tr>
<tr>
<td>( \text{Ga}<em>0.88\text{In}</em>{0.12}\text{As}<em>{0.11}\text{Sb}</em>{0.89} )</td>
<td>16.3 ± 0.5</td>
<td>8 ± 3</td>
<td>333.6a</td>
</tr>
<tr>
<td>( \text{Ga}<em>0.78\text{In}</em>{0.22}\text{As}<em>{0.19}\text{Sb}</em>{0.81} )</td>
<td>12.9 ± 0.5</td>
<td>8 ± 3</td>
<td>331.7a</td>
</tr>
</tbody>
</table>

\(^a\)Parameter fixed.
for only 4% of the shift at room temperature. The temperature dependence of the linewidth was described using a Bose-Einstein equation. The small value of $\Gamma_{\text{LO}}$ may be related to the relatively weak Fröhlich interaction in our materials in relation to other zinc-blende-type semiconductors.

We have implemented an IRPR system with capabilities at long wavelengths and utilized it to determine $E_0(T)$ and $\Gamma_0(T)$ for narrow band-gap materials.

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